

Notice of References Cited	Application/Control No. 10/713,000	Applicant(s)/Patent Under Reexamination ANDRIEU ET AL.	
	Examiner Alain L. Bashore	Art Unit 1762	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,567,219	10-1996	Vacha et al.	65/432
	B	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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